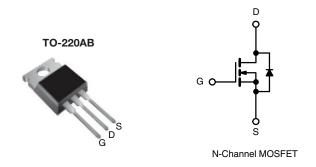
Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.85				
Q <sub>g</sub> max. (nC)	63				
Q <sub>gs</sub> (nC)	9.3				
Q <sub>gd</sub> (nC)	32				
Configuration	Single				



#### **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

#### **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF840PbF		
Lead (FD)-Iree	SiHF840-E3		
SnPb	IRF840		
SIPD	SiHF840		

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unles	s otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	500	V
Gate-Source Voltage			$V_{GS}$	± 20	V
Continuous Drain Current	V et 10 V	10 V $\frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$	I <sub>D</sub>	8.0	
Continuous Drain Current	VGS at 10 V	<sub>C</sub> = 100 °C		5.1	A
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	32	
Linear Derating Factor				1.0	W/°C
Single Pulse Avalanche Energy b			E <sub>AS</sub>	510	mJ
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	8.0	А
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	125	W
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.5	V/ns
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Soldering Recommendations (Peak temperature) d for 10 s			_	300	°C
Mounting Toyour	6-32 or M3 screw			10	lbf ⋅ in
Mounting Torque				1.1	N⋅m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50$  V, starting  $T_J=25$  °C, L=14 mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=8.0$  A (see fig. 12). c.  $I_{SD}\leq 8.0$  A,  $dI/dt\leq 100$  A/µs,  $V_{DD}\leq V_{DS}$ ,  $T_J\leq 150$  °C. d. 1.6 mm from case.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0			

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static		•			Į.		_
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.78	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	' <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
7 0		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V, \	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.8 A <sup>b</sup>	-	-	0.85	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	0 V, I <sub>D</sub> = 4.8 A <sup>b</sup>	4.9	-	-	S
Dynamic						•	
Input Capacitance	C <sub>iss</sub>	V	$V_{GS} = 0 \text{ V},$	-	1300	-	pF
Output Capacitance	C <sub>oss</sub>	V <sub>I</sub>	<sub>DS</sub> = 25 V,	-	310	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	120	-	
Total Gate Charge	Qg			-	-	63	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 b	-	-	9.3	
Gate-Drain Charge	Q <sub>gd</sub>	7	See lig. 0 and 15	-	-	32	
Turn-On Delay Time	t <sub>d(on)</sub>		V <sub>DD</sub> = 250 V, I <sub>D</sub> = 8 A		14	-	- ns
Rise Time	t <sub>r</sub>	$V_{DD} = 3$			23	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 9.1 \Omega$ , $R_D = 31 \Omega$ , see fig. 10 b		-	49	-	
Fall Time	t <sub>f</sub>			-	20	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") fro	Between lead, 6 mm (0.25") from		4.5	-	-11
Internal Source Inductance	L <sub>S</sub>	package and ce die contact	package and center of		7.5	-	- nH
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		0.6	-	2.8	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	8.0	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	32	A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 8 A, V <sub>GS</sub> = 0 V b		-	-	2.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 00 1			460	970	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}, I_F = 8 \text{A},  \text{dI/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	4.2	8.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn	-on time is negligible (turr	on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

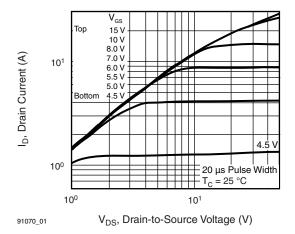


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

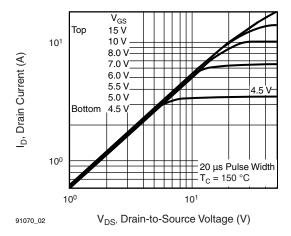


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

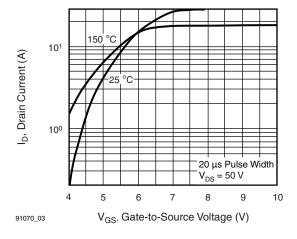


Fig. 3 - Typical Transfer Characteristics

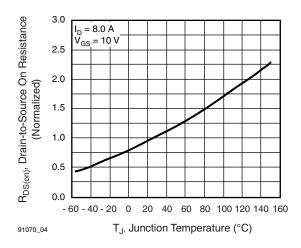


Fig. 4 - Normalized On-Resistance vs. Temperature

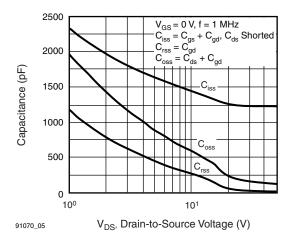


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

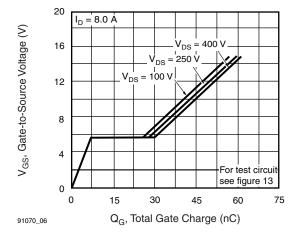


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



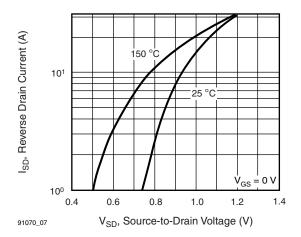


Fig. 7 - Typical Source-Drain Diode Forward Voltage

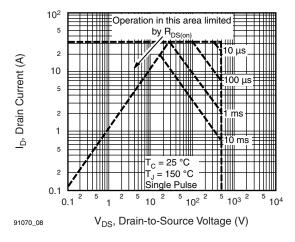


Fig. 8 - Maximum Safe Operating Area

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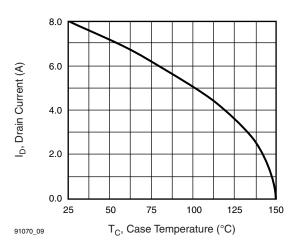


Fig. 9 - Maximum Drain Current vs. Case Temperature

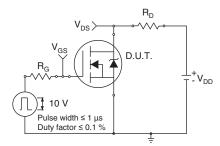


Fig. 10a - Switching Time Test Circuit

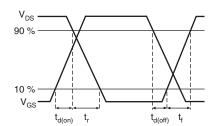


Fig. 10b - Switching Time Waveforms

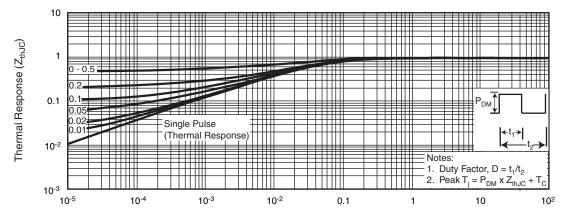
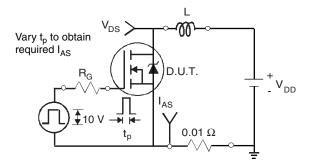
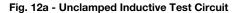


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







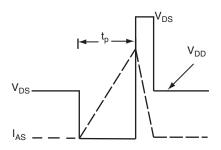


Fig. 12b - Unclamped Inductive Waveforms

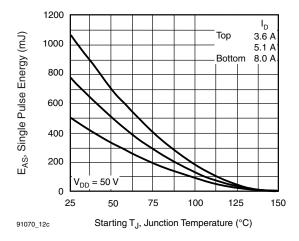


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

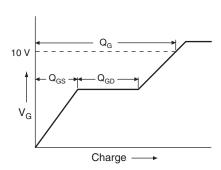


Fig. 13a - Basic Gate Charge Waveform

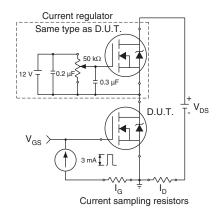
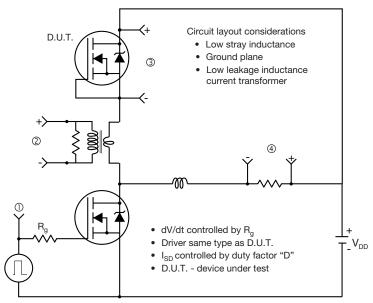


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



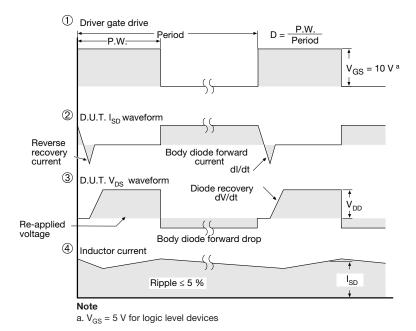


Fig. 14 - For N-Channel

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# TO-220-1



DIM	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

#### Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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